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CONFIRMATION NO. 4337

SERIAL NUMBER 10/695,245	FILING DATE 10/27/2003 RULE	CLASS 324	GROUP ART 2829	UNIT	ATTORNEY DOCKET NO. 6427-65559		
APPLICANTS							
James F. Orsillo, Bend, OR;							
This appln claims benefit of 60/454,102 03/11/2003 and is a CIP of 10/107,052 03/28/2002 which is a DIV of 09/662,735 09/15/2000 PAT 6,408,500 This application 10/695,245 is a CIP of 10/432,808 05/23/2003 which is a 371 of PCT/US01/28669 09/14/2001 This application 10/695,245 is a CIP of 10/439,595 05/16/2003 which claims benefit of 60/397,167 07/18/2002 and claims benefit of 60/454,102 03/11/2003 **FOREIGN APPLICATIONS*** **FOREIGN APPLICATIONS*** **FOREIGN FOREIGN FILING LICENSE GRANTED ** SMALL ENTITY ** *********************************							
Foreign Priority claimed 35 USC 119 (a-d) conditions	yes no Met afte	STATE OR	SHEETS	TOTAL	INDEPENDENT		
met Verified and	Allowance	COUNTRY OR	DRAWING 6	CLAIMS 43	CLAIMS 6		
ADDRESS 24197 KLARQUIST SPARKMAN, LLP 121 SW SALMON STREET SUITE 1600 PORTLAND, OR 97204							
TITLE Apparatus and method for use in testing a semiconductor wafer							

		☐ All Fees
		☐ 1.16 Fees (Filing)
FILING FEE	FEES: Authority has been given in Paper No to charge/credit DEPOSIT ACCOUNT	1.17 Fees (Processing Ext. of time)
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